Applicant(s)/Patent Under Application/Control No. Reexamination 10/531,916 TERADA ET AL. **Notice of References Cited** Examiner **Art Unit** Page 1 of 1 3682 Thomas R. Hannon **U.S. PATENT DOCUMENTS** Date **Document Number** Classification Name Country Code-Number-Kind Code MM-YYYY 384/288 US-2005/0196084 09-2005 Kitahara et al. Α * US-6,868,810 03-2005 Hojo et al. 384/288 В С US-US-D US-Ε US-F US-G US-Н US-US-J US-Κ US-US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν O Р Q R s

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